



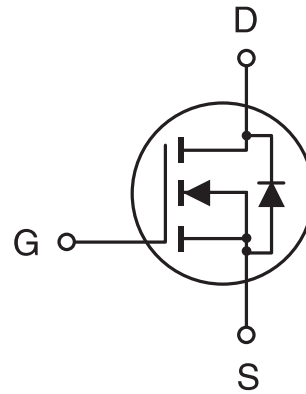
CEDF630/CEUF630

PRELIMINARY

N-Channel Enhancement Mode Field Effect Transistor

FEATURES

- 200V , 9A , $R_{DS(ON)}=400m\Omega$ @ $V_{GS}=10V$.
- Super high dense cell design for extremely low $R_{DS(ON)}$.
- High power and current handling capability.
- TO-251 & TO-252 package.



6

ABSOLUTE MAXIMUM RATINGS ($T_c=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	200	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous -Pulsed	I_D	9	A
	I_{DM}	40	A
Drain-Source Diode Forward Current	I_S	9	A
Maximum Power Dissipation @ $T_c=25^\circ C$ Derate above $25^\circ C$	P_D	50	W
		0.3	W/ $^\circ C$
Operating and Storage Temperature Range	T_J, T_{STG}	-65 to 175	$^\circ C$

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	3	$^\circ C/W$
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	50	$^\circ C/W$

CEDF630/CEUF630

ELECTRICAL CHARACTERISTICS (Tc=25°C unless otherwise noted)

6

Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D = 250μA	200			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 160V, V _{GS} = 0V			25	μA
Gate-Body Leakage	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
ON CHARACTERISTICS^a						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	2		4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} = 10V, I _D = 5A			400	mΩ
On-State Drain Current	I _{D(ON)}	V _{GS} = 10V, V _{DS} = 10V	10			A
Forward Transconductance	g _{FS}	V _{DS} = 10V, I _D = 5A	3			S
DYNAMIC CHARACTERISTICS^b						
Input Capacitance	C _{ISS}	V _{DS} = 25V, V _{GS} = 0V f = 1.0MHz		650	800	pF
Output Capacitance	C _{OSS}			110	250	pF
Reverse Transfer Capacitance	C _{RSS}			45	55	pF
SWITCHING CHARACTERISTICS^b						
Turn-On Delay Time	t _{D(ON)}	V _{DD} = 100V, I _D = 5A, V _{GS} = 10V, R _{GEN} = 50Ω		20	60	ns
Rise Time	t _r			75	120	ns
Turn-Off Delay Time	t _{D(OFF)}			70	80	ns
Fall time	t _f			35	50	ns
Total Gate Charge	Q _g	V _{DS} = 200V, I _D = 10A, V _{GS} = 10V		25	50	nC
Gate-Source Charge	Q _{gs}			5		nC
Gate-Drain Charge	Q _{gd}			7		nC

CEDF630/CEUF630

ELECTRICAL CHARACTERISTICS ($T_c=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS^a						
Diode Forward Voltage	V_{SD}	$V_{GS} = 0V, I_s = 10A$			1.5	V

6

Notes

- a. Pulse Test: Pulse Width $\leq 300 \mu s$, Duty Cycle $\leq 2\%$.
- b. Guaranteed by design, not subject to production testing.

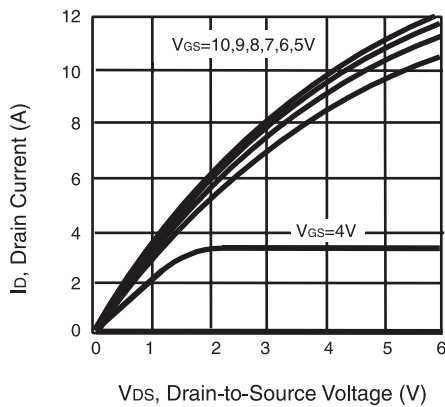


Figure 1. Output Characteristics

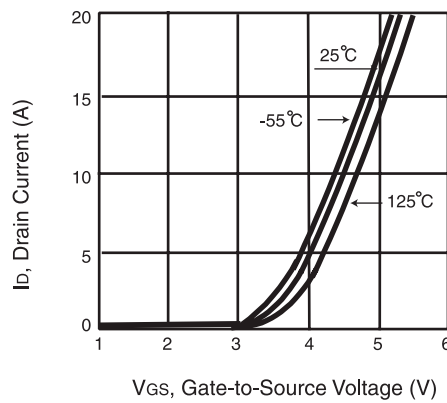


Figure 2. Transfer Characteristics

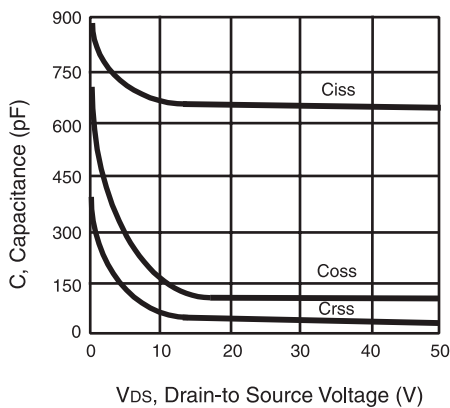


Figure 3. Capacitance

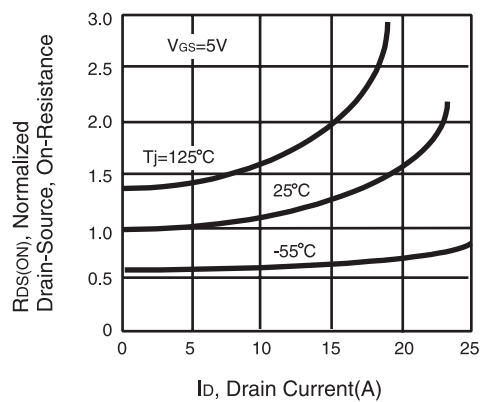


Figure 4. On-Resistance Variation with Drain Current and Temperature

CEDF630/CEUF630

6

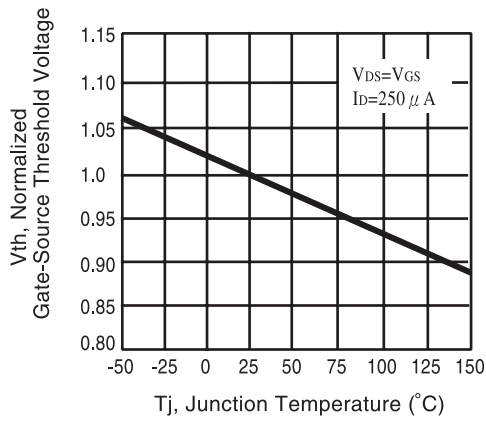


Figure 5. Gate Threshold Variation with Temperature

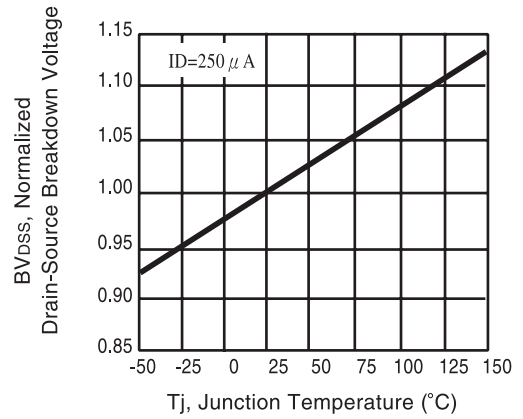


Figure 6. Breakdown Voltage Variation with Temperature

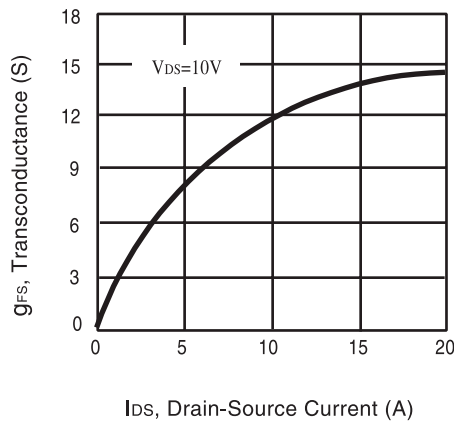


Figure 7. Transconductance Variation with Drain Current

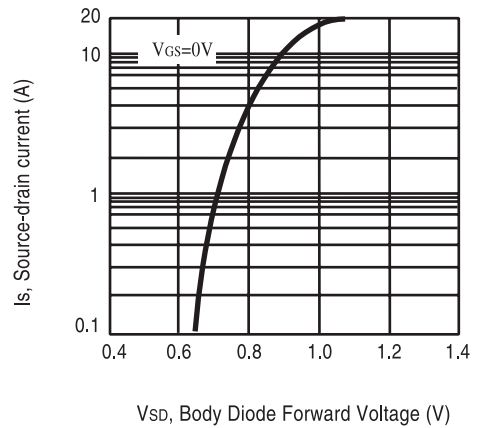


Figure 8. Body Diode Forward Voltage Variation with Source Current

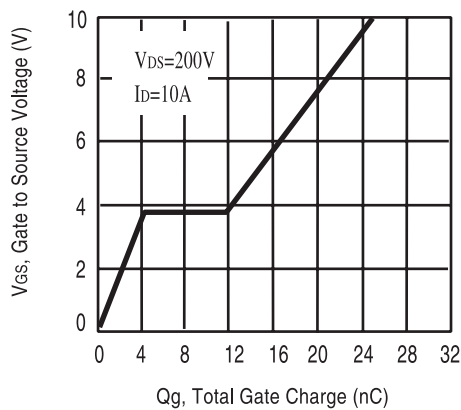


Figure 9. Gate Charge

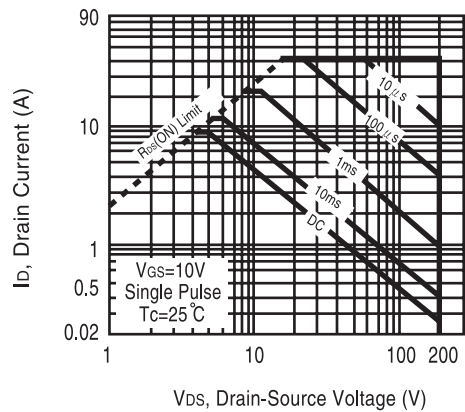


Figure 10. Maximum Safe Operating Area

CEDF630/CEUF630

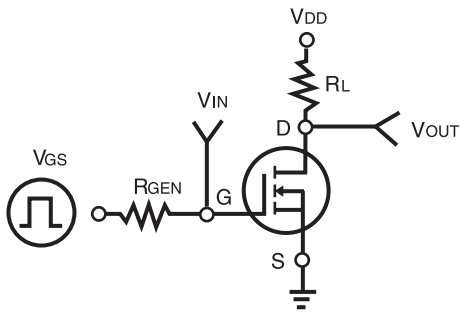


Figure 11. Switching Test Circuit

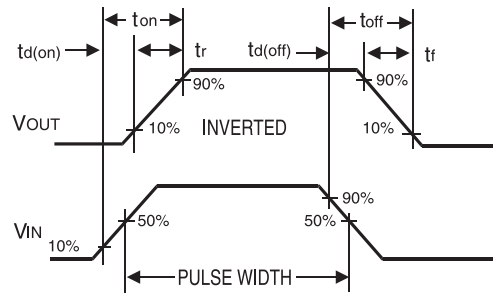


Figure 12. Switching Waveforms

6

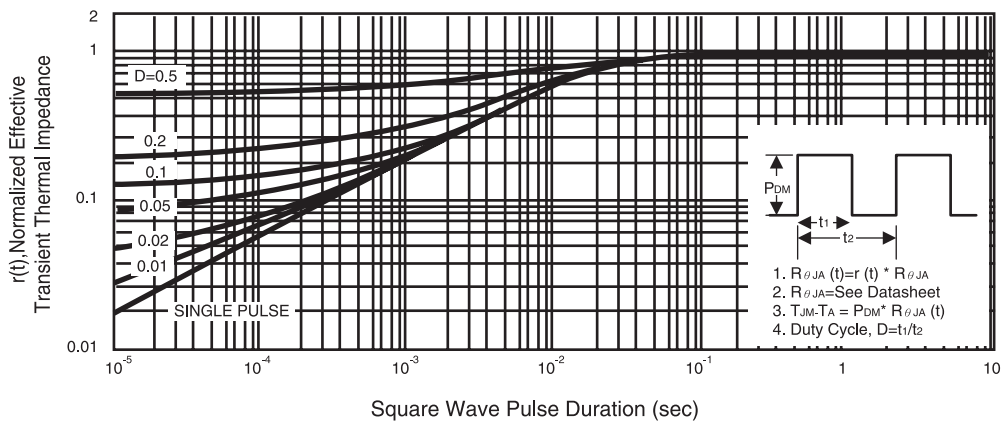


Figure 13. Normalized Thermal Transient Impedance Curve